

L Number	Hits	Search Text	DB	Time stamp
1	2702	257/59	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/11 11:17
2	2252	257/72	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/11 11:16
3	0	257/72 and (electromagnetic adj detector) and charge	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/11 11:16
4	0	257/72 and (electromagnetic adj detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/11 11:17
5	0	257/59 and (electromagnetic adj detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/11 11:18
-	1	20020131011.pn.	USPAT; US-PGPUB	2004/05/10 14:01
-	515	electromagnetic adj detector	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 14:02
-	1598	349/158	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 14:04
-	61	(electromagnetic adj detector) and charge	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/11 11:15
-	153	(electromagnetic adj (detector measure\$4 test\$4))and charge	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 15:05
-	58	(electromagnetic adj (detector measure\$4 test\$4))and charge and (uneven\$4 concave convex) and bond\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 15:15
-	1068	(electromagnetic adj (detector measure\$4 test\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 15:15
-	52	(electromagnetic adj (detector measure\$4 test\$4))and uneven and charge and semiconductor	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 16:14
-	328	349/199.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 15:31

2	349/199 and (uneven concave convex) and (semiconductor\$4 near10 charge)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 15:31
21	349/199 and (uneven concave convex)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 15:31
154	250/267	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 16:03
393	250/265	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 16:06
167	250/339.14	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 16:11
2	(electromagnetic) and uneven and charge and ((semiconductor near10 (charge pixel)) same (convex or concave))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 16:17
3	uneven and charge and ((semiconductor near10 (charge pixel)) same (convex or concave))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 16:25
8	uneven and ((semiconductor near10 (charge or pixel)) same (convex or concave))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 17:10
25	uneven and ((semiconductor near10 (charge or pixel)) and (convex or concave)) and peel\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 17:11
177	uneven and ((semiconductor near10 (charge or pixel)) and (convex or concave))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/10 17:27